

N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)	
100	0.187 at V _{GS} = 10 V	3	7.3 nC	

FEATURES

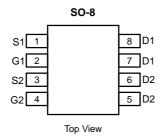
- DT-Trench Power MOSFET
- 100 % R_q and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

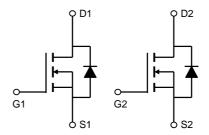


COMPLIANT

APPLICATIONS

- DC/DC Conversion
 - Notebook System Power





Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V_{DS}	100	V	
Gate-Source Voltage		V_{GS}	±30	V	
Continuous Drain Current	T _A =25℃		3.0		
	T _A =70℃	'D	2.5	Α	
Pulsed Drain Current ^C		I _{DM}	12	1	
Avalanche Current ^C		I _{AR}	3	A	
Repetitive avalanche energy L=0.1mH ^C		E _{AR}	12.8	mJ	
Power Dissipation ^B	T _A =25℃	В	2	W	
	T _A =70℃	P _D	1.3	v	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C	

Thermal Characteristics						
Parameter	Symbol	Тур	Max	Units		
Maximum Junction-to-Ambient A	t ≤ 10s	D	48	62.5	€/W	
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	74	90	€\M	
Maximum Junction-to-Lead	Steady-State	$R_{ hetaJL}$	32	40	℃/W	





Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Тур	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
	Zero Gate Voltage Drain Current	V _{DS} =80V, V _{GS} =0V			1	^
I _{DSS}		T _J =55℃	;		5	μΑ
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±30V			100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	1	2	3	V
$I_{D(ON)}$	On state drain current	V _{GS} =10V, V _{DS} =5V				Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =2.5A		187		mΩ
		T _J =125℃	;	193.0		
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =2.5A		15		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.77	1	V
I_S	Maximum Body-Diode Continuous Current				2.5	Α
I _{SM}	Pulsed Body-diode Current ^C				18	Α
DYNAMIC	PARAMETERS					
C _{iss}	Input Capacitance			640	770	pF
Coss	Output Capacitance	V_{GS} =0V, V_{DS} =40V, f=1MHz	28	40	52	pF
C _{rss}	Reverse Transfer Capacitance		12	20	30	pF
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		1.8	2.7	Ω
SWITCHII	NG PARAMETERS					
Q _g (10V)	Total Gate Charge		8	11	13	nC
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =40V, I _D =2.5A	4	5.5	7	
Q_{gs}	Gate Source Charge	VGS-10V, VDS-40V, ID-2.0A	4	5	6	nC
Q_{gd}	Gate Drain Charge		0.7	1.2	1.7	nC
t _{D(on)}	Turn-On DelayTime			7.2		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =40V, R_L =8 Ω ,		2.2		ns
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}=3\Omega$		17		ns
t _f	Turn-Off Fall Time	7		2		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =2.5A, dI/dt=300A/μs		20	26	ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =2.5A, dI/dt=300A/μs	35	50	65	nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using \leq 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150$ °C. Ratings are based on low frequency and duty cycles to keep initial $T_J=25$ °C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

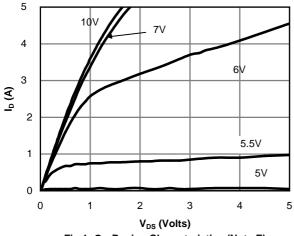
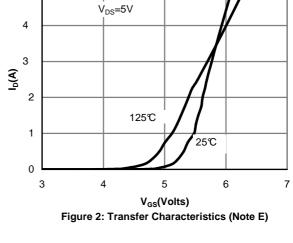


Fig 1: On-Region Characteristics (Note E)



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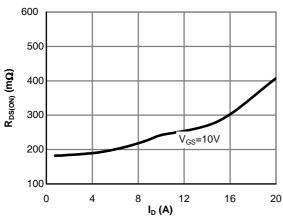


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

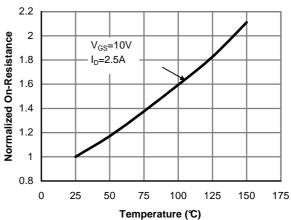


Figure 4: On-Resistance vs. Junction Temperature (Note E)

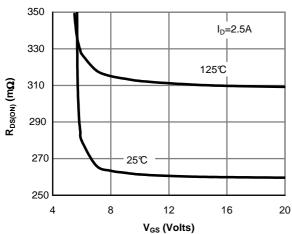


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

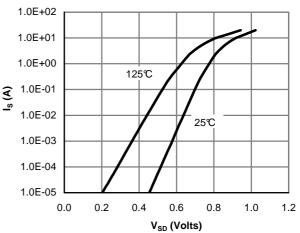


Figure 6: Body-Diode Characteristics (Note E)



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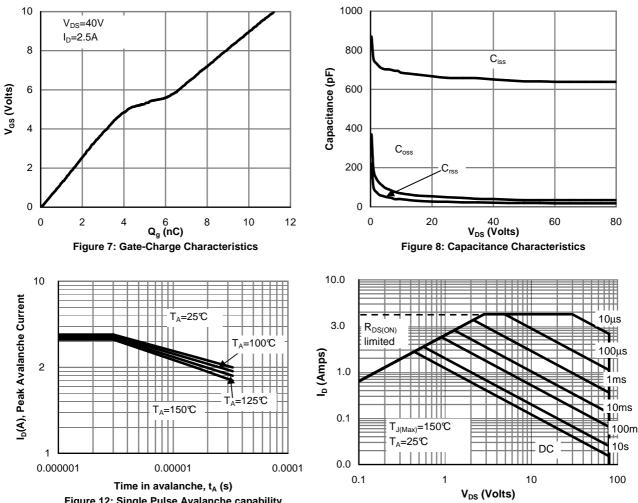
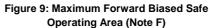


Figure 12: Single Pulse Avalanche capability



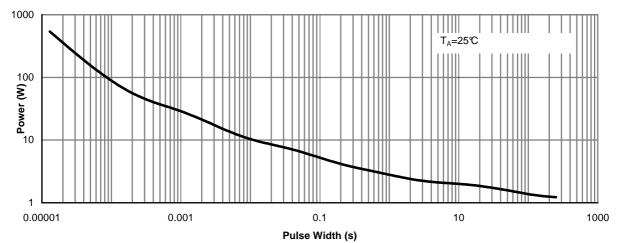


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)





TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

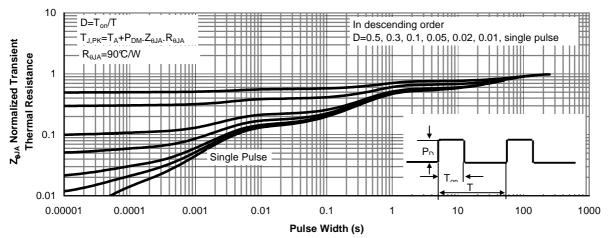


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)





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